Substitute for form 1449A/PTO	Complete If Known	
INFORMATION DISCLOSURE STATEMENT BY APPLICANT	Application No.	10/612,198
	Filing Dat	July 1, 2003
	First Named Inventor	Carey Nachenberg
	Art Unit	not yet known
	Examiner Name	not yet known
Sheet 1 of 1	Attorney Docket Number	20423-07775

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Examiner Initials*	Cite No.[1]	Document No. Number – Kind Code[2] (if known)	Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document
JL	A	US 2003/0037251 A1	02-20-2003	Frieder et al.
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OTHER REFERENCES – NON-PATENT LITERATURE DOCUMENTS

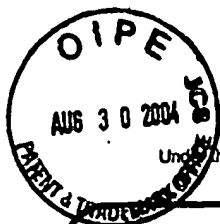| Examiner Initials*	Cite No.[1]	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published	T[6]
JL	E	Chung, Christina Yip, Gertz, Michael, and Levitt, Karl; *DEMIDS: A Misuse Detection System For Database Systems*; Department of Computer Science, University of California at Davis; October 1, 1999; pp. 1-18.	
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Examiner Signature	/Jaric Loving/	Date Considered	06/28/2006

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INFORMATION DISCLOSURE STATEMENT BY APPLICANT	Application No.	10/612,198
	Filing Date	July 1, 2003
	First Named Inventor	Carey Nachenberg
	Art Unit	2131
	Examiner Name	Not Yet Known
Sheet 1 of 1	Attorney Docket Number	20423-07775

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JL		LOW, WAI LUP, ET AL., "DIDAFIT: Detecting Intrusions In Databases Through Fingerprinting Transactions," ICEIS 2002, Fourth International Conference On Enterprise Information Systems, Vol. 1, April 3-6, 2002, pp. 121-128, Ciudad Real, Spain.	

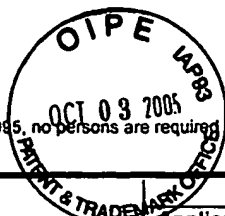| Examiner Signature	/Jaric Loving/	Date Considered	06/28/2006

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			Art Unit	2131	
			Examiner Name	Not Yet Known	
Sheet	1	of	1	Attorney Docket Number	20423-07775

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